N-Ch MOSFET

General Description

The WSP4068 is the highest performance trench N-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSP4068 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

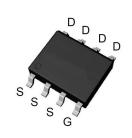
Product Summery

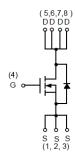
BVDSS	RDSON	ID
40V	16.5mΩ	10A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

S0P-8 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	10	Α
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	9	Α
I _{DM}	Pulsed Drain Current ²	30	Α
EAS	Single Pulse Avalanche Energy ³	26	mJ
I _{AS}	Avalanche Current	23	Α
P _D @T _A =25℃	Total Power Dissipation ⁴	2.08	W
T _{STG}	Storage Temperature Range -55 to 150		$^{\circ}$
TJ	Operating Junction Temperature Range -55 to 150		$^{\circ}$ C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹		65	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		20	°C/W

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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.024		V/°C
Б	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =12A		13.5	16.5	6
$R_{DS(ON)}$		V _{GS} =4.5V , I _D =10A		19	24.5	mΩ
V _{GS(th)}	Gate Threshold Voltage	\\ -\\ -250\	1.5	1.8	2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-5.07		mV/℃
	Drain Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25℃			1	uA
I _{DSS}	Drain-Source Leakage Current	V_{DS} =24V , V_{GS} =0V , T_{J} =55 $^{\circ}$ C			30	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20 V$, V_{DS} = $0 V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =8A		31		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.1	1.8	Ω
Q_g	Total Gate Charge (4.5V)	V _{DS} =15V , V _{GS} =4.5V , I _D =12A		9.4		
Q_{gs}	Gate-Source Charge			3.9		nC
Q_{gd}	Gate-Drain Charge			3.0		
T _{d(on)}	Turn-On Delay Time	V_{DD} =15V , V_{GS} =10V , R_{G} =6 Ω I_{D} =1A , R_{L} =15 Ω		12	14	
Tr	Rise Time			10	17	no
T _{d(off)}	Turn-Off Delay Time			23	42	ns
T _f	Fall Time			6	12	
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		1125		
C _{oss}	Output Capacitance			132		pF
C _{rss}	Reverse Transfer Capacitance			70		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.1mH , I _{AS} =23A		26		mJ

Diode Characteristics

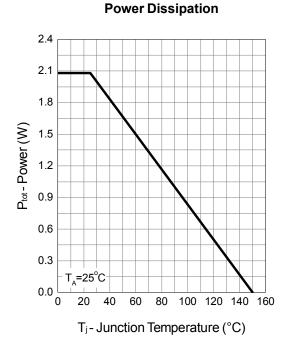
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,6}	V =V =0V Force Current			8	Α
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V , Force Current			38	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.1	V
t _{rr}	Reverse Recovery Time			15		nS
Q _{rr}	Reverse Recovery Charge	IF=12A , dI/dt=100A/ μ s , T $_{J}$ =25 $^{\circ}$ C		9.5		nC

Note

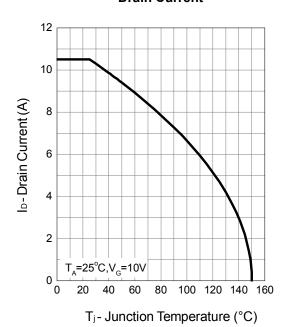
- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10 sec.
- 2.The data tested by pulsed , pulse width $\,\leq\,300\text{us}$, duty cycle $\,\leq\,2\%$
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=23A
- 4.The power dissipation is limited by 150 ℃ junction temperature
- 5.The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



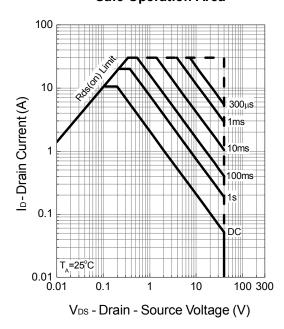
Typical Characteristics



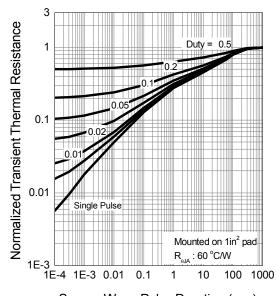
Drain Current



Safe Operation Area

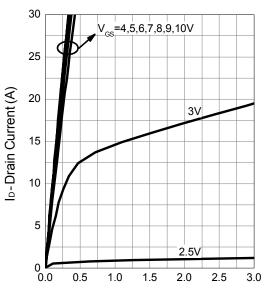


Thermal Transient Impedance



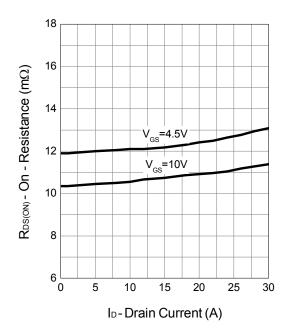


Output Characteristics

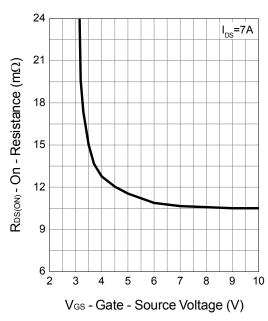


V_{DS} - Drain - Source Voltage (V)

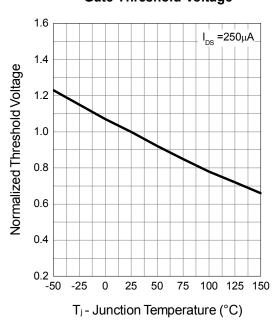
Drain-Source On Resistance



Gate-Source On Resistance

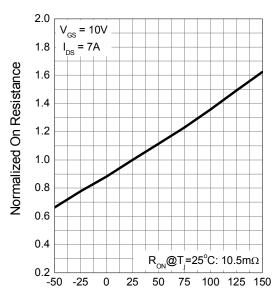


Gate Threshold Voltage



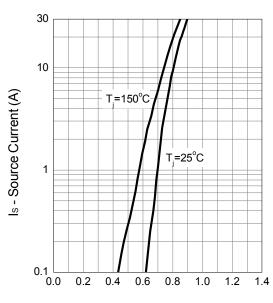


Drain-Source On Resistance



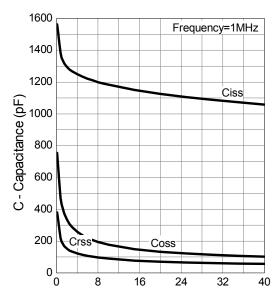
T_j-Junction Temperature (°C)

Source-Drain Diode Forward



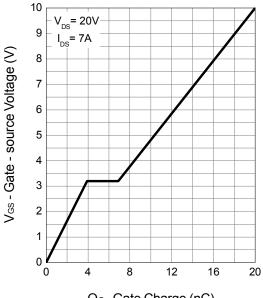
VsD - Source - Drain Voltage (V)

Capacitance



V_{DS} - Drain - Source Voltage (V)

Gate Charge



Q_G-Gate Charge (nC)



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